



**International
Standard**

ISO 25498

**Microbeam analysis — Analytical
electron microscopy — Selected
area electron diffraction analysis
using a transmission electron
microscope**

*Analyse par microfaisceaux — Microscopie électronique
analytique — Analyse par diffraction par sélection d'aire au
moyen d'un microscope électronique en transmission*

**Third edition
2025-05**



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